

Notice of References Cited

Application/Control No.

10/729,937

Applicant(s)/Patent Under
Reexamination
SHIBAMIYA ET AL.

Examiner

JASON K. LIN

Art Unit

2425

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,133,962	10-2000	Proehl et al.	725/44
*	B	US-5,808,608	09-1998	Young et al.	725/52
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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